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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/809,519	SHIRAISHI ET AL.	
Examiner	Art Unit	
Peter D. Mulcahy	1713	

SEARCHED			
Class	Subclass	Date	Examiner
524	110,111 112,376	11/15/2006	PDM
152	525	11/15/2006	PDM

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Class	Subclass	Date	Examiner		
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